

Search Notes

Application/Control No.

09/588,617

Examiner

Trung Q. Nguyen

Applicant(s)/Patent under
Reexamination

BERTIN ET AL.

Art Unit

2829

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Search Keywords: semiconductor\$1, carrier\$1, socket\$1, burn\$3, test\$3 and chip\$1	9/7/2005	QT